

DESCRIPTION

The LX5535 is a power amplifier optimized for WLAN applications in the 2.4-2.5 GHz frequency range. The PA is implemented as a three-stage monolithic microwave integrated circuit (MMIC) with active bias and output pre-matching.

The device is manufactured with an InGaP/GaAs Heterojunction Bipolar Transistor (HBT) IC process (MOCVD). With single low voltage supply of 5V, it provides 32 dB power gain between 2.4-2.5GHz, at a low quiescent current of 120mA.

The output power for EVM(Error Vector Magnitude) of 3.5% is 25dBm (64QAM/54Mbps), where the PA consumes 260mA total DC current.

The LX5535 is available in a 16-pin 3mm x 3mm micro-lead package (MLPQ-16L). The compact footprint, low profile, and thermal capability of the MLP package makes the LX5535 an ideal solution for high-gain power amplifier requirements for IEEE 802.11b/g and WiMAX applications.

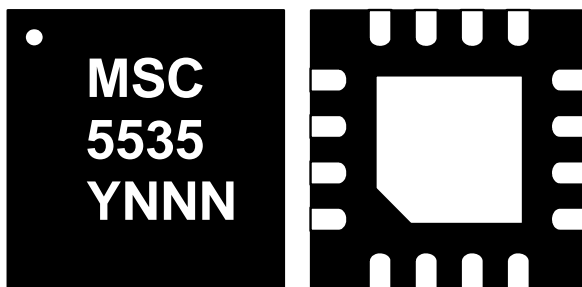
IMPORTANT: For the most current data, consult MICROSEMI's website: <http://www.microsemi.com>

KEY FEATURES

- Advanced InGaP HBT
- 2.4-2.5GHz Operation
- Single-Polarity 3-5V Supply
- Quiescent Current 120mA
- Power Gain 32 dB
- Power for EVM~3.5 %
- 54Mbps/64QAM : 25dBm
- Total Current 260mA for Pout=25dBm, 802.11g
- 802.11b mask-compliant power : 28dBm
- Total Current 370mA for Pout=+28dBm, 802.11b
- Small Footprint: 3x3mm²
- Low Profile: 0.9mm

APPLICATIONS

- IEEE 802.11b/g
- IEEE 802.16 WiMAX

PRODUCT HIGHLIGHT


(YNNN : Trace code)

PACKAGE ORDER INFO

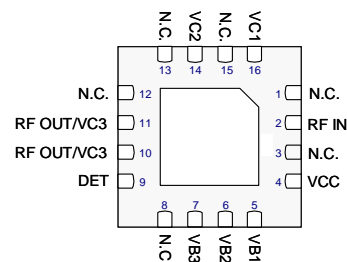
| | |
|-----------------|--------------------------|
| | Plastic MLPQ |
| LQ | 3x3 16 pin |
| | RoHS Compliant / Pb-free |
| LX5535LQ | |

Note: Available in Tape & Reel.
Append the letter "TR" to the part number.
(i.e. LX5535LQ-TR)

ABSOLUTE MAXIMUM RATINGS

| | |
|--|----------------|
| DC Supply Voltage, RF off..... | 6.0V |
| Collector Current..... | 800mA |
| Total Power Dissipation..... | 4W |
| RF Input Power (With 50 Ohm Load at Output)..... | +15dbm |
| Maximum Operating Junction Temperature (T _{Jmax})..... | +150°C |
| Operation Ambient Temperature Range (T _A)..... | -40 to +85°C |
| Storage Temperature..... | -65 to +150°C |
| Package Peak Temp. for Solder Reflow (40 seconds maximum exposure) | +260°C (+0,-5) |

Note: Exceeding these ratings could cause damage to the device. All voltages are with respect to Ground. Currents are positive into, negative out of specified terminal.

PACKAGE PIN OUT


LQ PACKAGE
(Bottom View)

RoHS / Pb-free 100% matte Tin Lead Finish

THERMAL DATA
LQ Plastic MLP16L 16-Pin

| | |
|---|------------------|
| THERMAL RESISTANCE-JUNCTION TO CASE, θ_{JC} | 25.3 °C/W |
| THERMAL RESISTANCE-JUNCTION TO AMBIENT, θ_{JA} | 80.5 °C/W |

Junction Temperature Calculation : $T_J = T_A + (P_D \times \theta_{JA})$.

The θ_{JA} numbers are guidelines for the thermal performance of the device/pc-board system. All of the above assume no ambient airflow.

FUNCTIONAL PIN DESCRIPTION

| Name | Pin | Description |
|--------|---------------------|--|
| RF IN | 2 | RF input for the power amplifier. This pin is DC-shorted to GND but AC-coupled to the transistor base of the first stage. |
| VB1 | 5 | Bias current control voltage for the first stage. |
| VB2 | 6 | Bias current control voltage for the second stage. |
| VB3 | 7 | Bias current control voltage for the third stage. |
| VCC | 4 | Supply voltage for the bias reference and control circuits. |
| RF OUT | 10, 11 | RF output and power supply for the third stage amplifier. |
| VC1 | 16 | Power supply for the first stage amplifier. |
| VC2 | 14 | Power supply for the second stage amplifier. |
| DET | 9 | DETECTOR output. |
| GND | Center Metal | The center metal base of the MLP package provides both DC and RF ground as well as heat sink for the power amplifier. |
| NC | 1, 3, 8, 12, 13, 15 | These pins are unused and not connected to the device inside the package. They can be treated either as open pins, or connected for ground for better heat dissipation |

ELECTRICAL CHARACTERISTICS

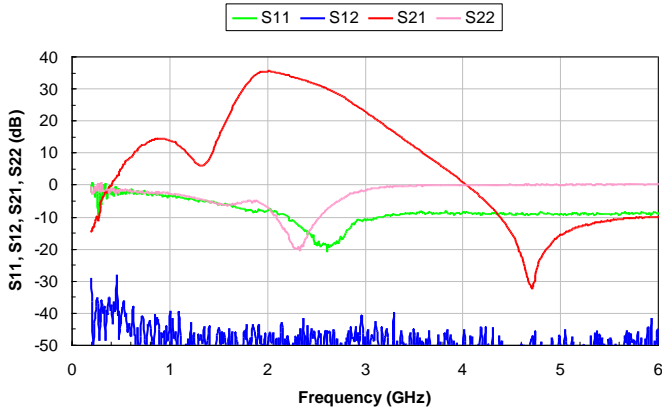
Unless otherwise specified, the following specifications apply for the following test conditions:

$V_c = V_{cc} = 5V$, $V_{ref} = 2.9V$, $I_{cq} = 120mA$, $T_A = 25^\circ C$

| Parameter | Symbol | Test Conditions | LX5535 | | | Units |
|--------------------------------|-----------------|------------------------------|--------|------|-----|-------|
| | | | Min | Typ | Max | |
| SECTION HEADER | | | | | | |
| Frequency Range | f | | 2.4 | 2.45 | 2.5 | GHz |
| Power Gain | Gp | Pout=25dBm | | 32 | | dB |
| Power for EVM = 3.5% | | 64QAM / 54Mbps | | 25 | | dBm |
| Total Current at Pout = 25dBm | | 64QAM / 54Mbps | | 260 | | mA |
| Quiescent Current | Icq | | | 120 | | mA |
| Bias Control Reference Current | Iref | For Icq = 120mA | | 2 | | mA |
| Small-Signal Gain | S21 | | | 32 | | dB |
| Gain Flatness | ΔS_{21} | Over 200MHz | | 2 | | dB |
| Input Return Loss | S11 | | | 10 | | dB |
| Output Return Loss | S22 | | | 10 | | dB |
| Reverse Isolation | S12 | | | 50 | | dB |
| Second Harmonic | | Pout = 28dBm, CW | | -40 | | dBc |
| 802.11b mask compliant power | | 1 Mbps DSSS | | 28 | | dBm |
| Total Current at Pout=28dBm | | 1 Mbps DSSS | | 370 | | mA |
| Ramp-On Time | t _{ON} | 10 ~ 90% | | 100 | | ns |
| Detector Response | DET | Pout = 25dBm, 64QAM / 54Mbps | | 1.5 | | V |

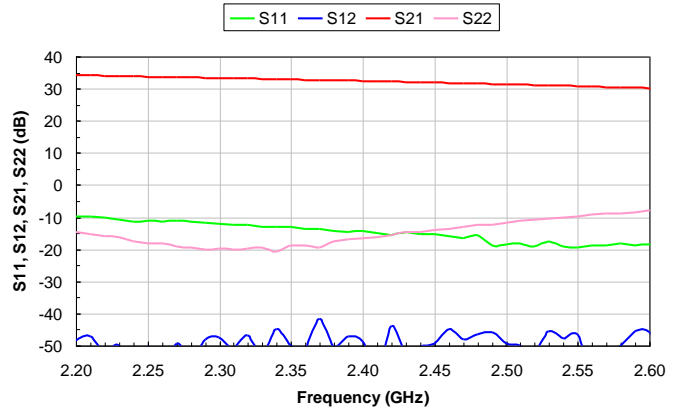
Note: All measured data was obtained on a 10 mil GETEK evaluation board without heat sink.

S-PARAMETER



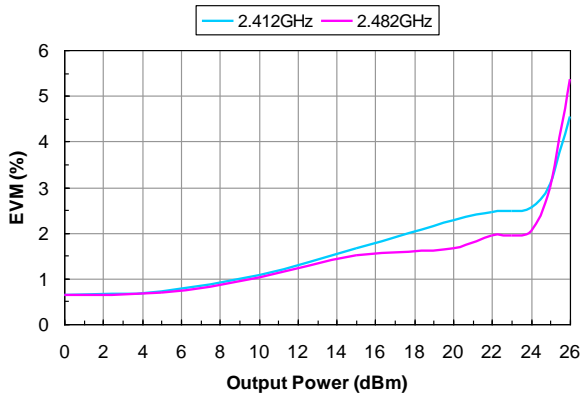
Typical S-Parameter Data at Room Temp.
($V_c = V_{cc} = 5.0V$, $V_{ref} = 2.9V$, $I_{cq} = 120mA$)

IN-BAND S-PARAMETER



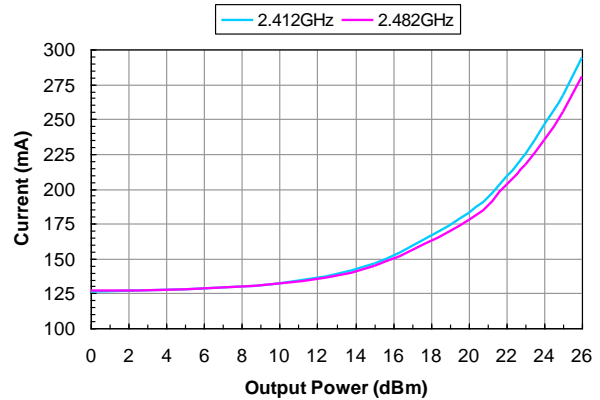
Typical S-Parameter Data at Room Temp.
($V_c = V_{cc} = 5.0V$, $V_{ref} = 2.9V$, $I_{cq} = 120mA$)

EVM VS. POUT



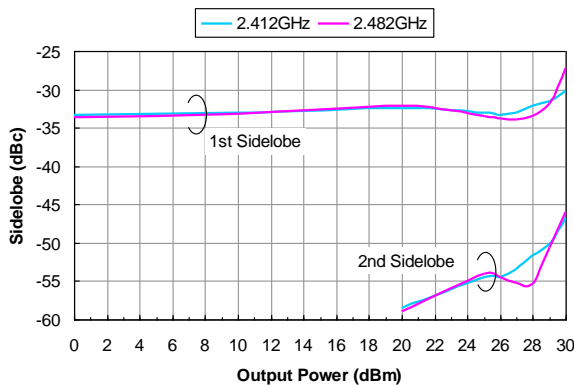
Typical EVM vs. Pout at Room Temp.
($V_c = V_{cc} = 5.0V$, $V_{ref} = 2.9V$, $I_{cq} = 120mA$, 64QAM/54Mbps, 90% duty cycle)

TOTAL CURRENT VS. POUT (OFDM)



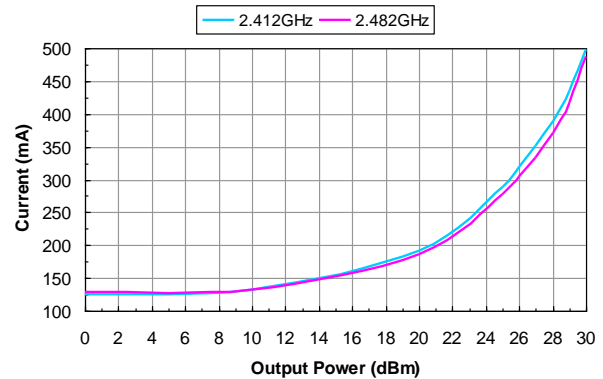
Typical Current vs. Pout at Room Temp.
($V_c = V_{cc} = 5.0V$, $V_{ref} = 2.9V$, $I_{cq} = 120mA$, 64QAM/54Mbps, 90% duty cycle)

1MBPS DSSS SIDELobe VS. POUT



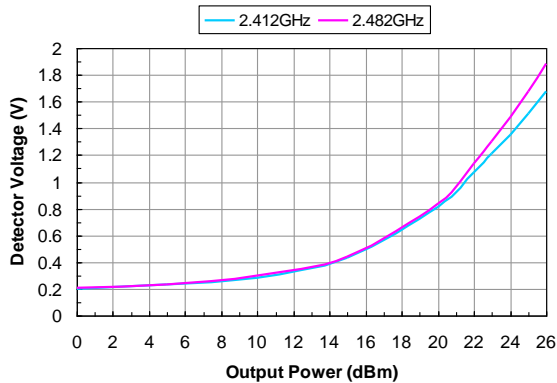
Typical 1Mbps DSSS Sidelobe vs. Pout at Room Temp.
($V_c = V_{cc} = 5.0V$, $V_{ref} = 2.9V$, $I_{cq} = 120mA$, 1Mbps DSSS, 99% duty cycle)

TOTAL CURRENT VS. POUT (DSSS)



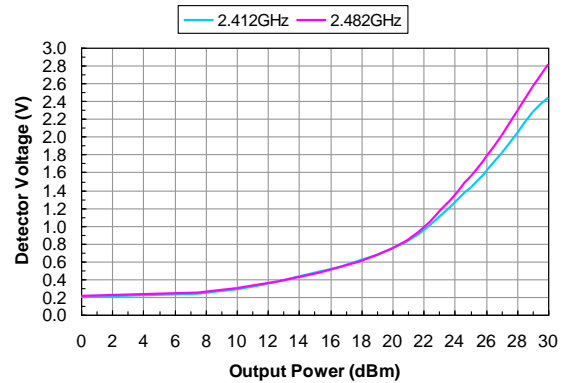
Typical Current vs. Pout at Room Temp.
($V_c = V_{cc} = 5.0V$, $V_{ref} = 2.9V$, $I_{cq} = 120mA$, 1Mbps DSSS, 99% duty cycle)

DETECTOR VS. POUT (OFDM)



Typical Detector Output vs. Pout at Room Temp.
($V_c = V_{cc} = 5.0V$, $V_{ref} = 2.9V$, $I_{cq} = 120mA$, 64QAM/54Mbps, 90% duty cycle)

DETECTOR VS. POUT (DSSS)



Typical Detector Output vs. Pout at Room Temp.
($V_c = V_{cc} = 5.0V$, $V_{ref} = 2.9V$, $I_{cq} = 120mA$, 1Mbps DSSS, 99% duty cycle)

OFDM SPECTRUM AT +29DBM, 2.412GHZ



Typical OFDM Output Spectrum at +29dBm, 2.412GHz
($V_c = V_{cc} = 5.0V$, $v_{ref} = 2.9V$, $I_{cq} = 120mA$, 64QAM/54Mbps)

OFDM SPECTRUM AT +29DBM, 2.482GHZ



Typical OFDM Output Spectrum at +29dBm, 2.482GHz
($V_c = V_{cc} = 5.0V$, $V_{ref} = 2.9V$, $I_{cq} = 120mA$, 64QAM/54Mbps)

DSSS SPECTRUM AT +28DBM, 2.412GHZ

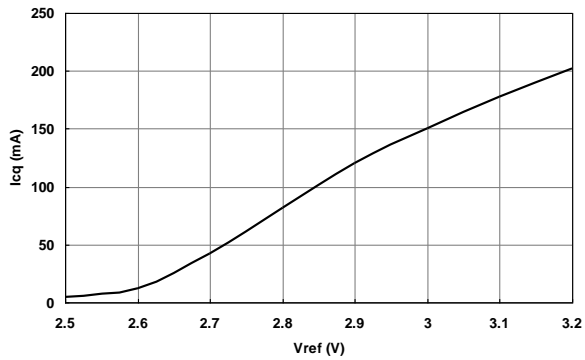


Typical 1Mbps DSSS output spectrum at +28dBm, 2.412GHz
($V_c = V_{cc} = 5.0V$, $V_{ref} = 2.9V$, $I_{cq} = 120mA$, 1Mbps DSSS)

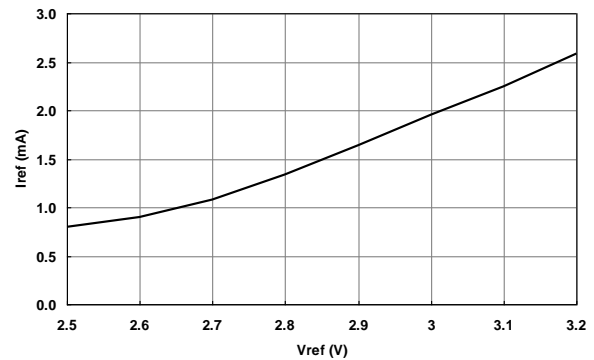
DSSS SPECTRUM AT +28DBM, 2.482GHZ



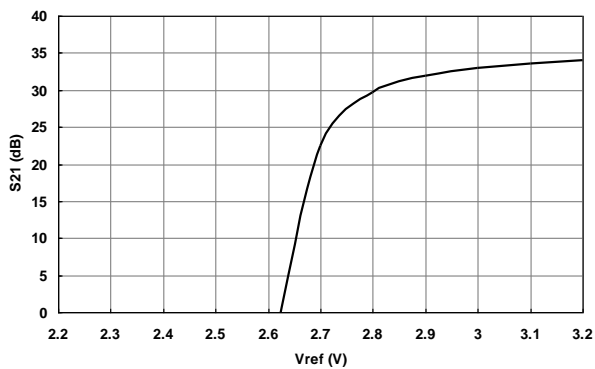
Typical 1Mbps DSSS output spectrum at +28dBm, 2.482GHz
($V_c = V_{cc} = 5.0V$, $V_{ref} = 2.9V$, $I_{cq} = 120mA$, 1Mbps DSSS)

QUIESCENT CURRENT VS. BIAS VREF


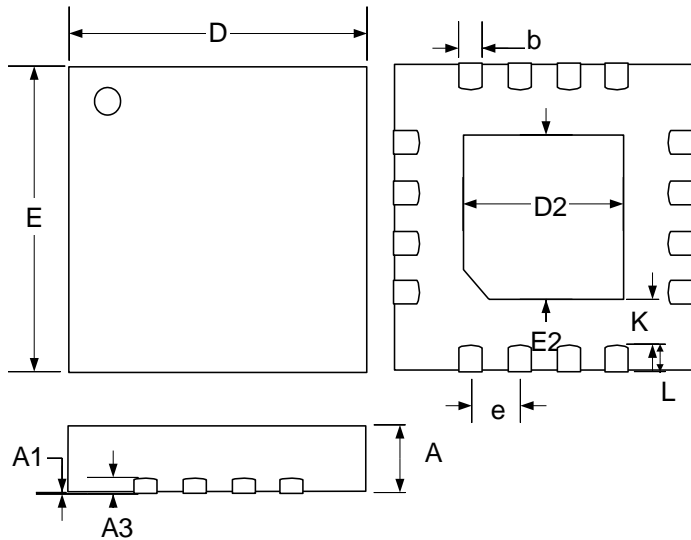
Typical Quiescent Current (Icq) vs. Bias Control Volgate (Vref) at Room Temp.
(Nominal Bias : Vc = Vcc = 5.0V, Vref=2.9V, Icq = 120mA)

BIAS CONTROL CURRENT VS. BIAS VREF


Typical Bias Control Current (Iref) vs. Bias Control Volgate (Vref) at Room Temp.
(Nominal Bias : Vc = Vcc = 5.0V, Vref = 2.9V, Icq = 120mA)

SMALL SIGNAL GAIN VS. BIAS VREF


Typical Small Signal Gain vs. Bias Control Volgate (Vref) at Room Temp.
(Nominal Bias : Vc = Vcc = 5.0V, Vref=2.9V, Icq = 120mA)

PACKAGE DIMENSIONS
LQ 16-Pin MLPQ 3x3


| Dim | MILLIMETERS | | INCHES | |
|-----|-------------|------|-----------|-------|
| | MIN | MAX | MIN | MAX |
| A | 0.80 | 1.00 | 0.031 | 0.039 |
| A1 | 0 | 0.05 | 0 | 0.002 |
| A3 | 0.20 REF | | 0.008 REF | |
| b | 0.18 | 0.30 | 0.007 | 0.012 |
| D | 3.00 BSC | | 0.118 BSC | |
| E | 3.00 BSC | | 0.118 BSC | |
| e | 0.50 BSC | | 0.020 BSC | |
| D2 | 1.30 | 1.55 | 0.051 | 0.061 |
| E2 | 1.30 | 1.55 | 0.051 | 0.061 |
| K | 0.2 | - | 0.008 | - |
| L | 0.35 | 0.50 | 0.012 | 0.020 |

Note:

- Dimensions do not include mold flash or protrusions; these shall not exceed 0.155mm(.006") on any side. Lead dimension shall not include solder coverage.

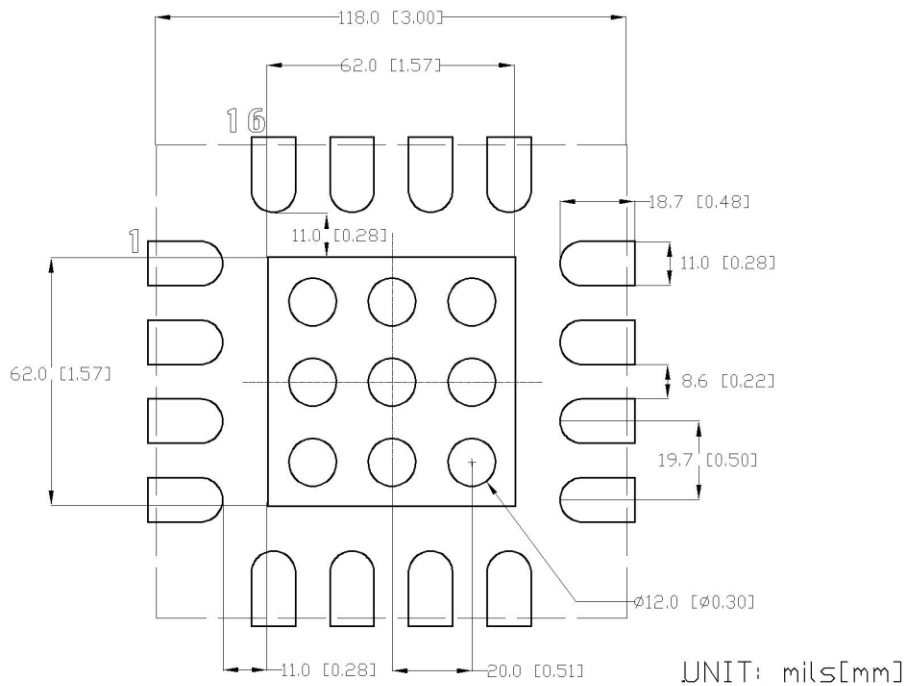


Figure – Recommended Land Pattern



a  MICROCHIP company

LX5535

InGaP HBT 2.4 – 2.5 GHz Power Amplifier

PRODUCTION DATA SHEET

NOTES

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